

Notice of References Cited

Application/Control No.

10/520,795

Applicant(s)/Patent Under
Reexamination
CASTRO ET AL.

Examiner

HEE SOO KIM

Art Unit

2157

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,204,955 A	04-1993	Kagei et al.	714/55
*	B	US-5,579,384 A	11-1996	Seymour, James M.	379/243
*	C	US-6,041,350 A	03-2000	Takimoto, Minoru	709/223
*	D	US-6,212,169 B1	04-2001	Bawa et al.	370/252
*	E	US-6,363,411 B1	03-2002	Dugan et al.	709/202
*	F	US-2002/0176423 A1	11-2002	Godin et al.	370/395.2
*	G	US-6,779,030 B1	08-2004	Dugan et al.	709/223
*	H	US-2006/0015617 A1	01-2006	Castro et al.	709/226
*	I	US-7,065,053 B2	06-2006	Godin et al.	370/252
*	J	US-7,225,250 B1	05-2007	Harrop, Thomas C.	709/224
*	K	US-2002/0029298 A1	08-2001	Wilson, Magnus	709/316
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.